

# AONS66923

# 100V N-Channel AlphaSGT™

### **General Description**

- Trench Power AlphaSGT $^{TM}$  technology
- $\bullet \ Low \ R_{DS(ON)}$
- Logic Level Driving
- Excellent Q<sub>G</sub> x R<sub>DS(ON)</sub> Product (FOM)
- Spike Optimized Process
- RoHS and Halogen-Free Compliant

## **Applications**

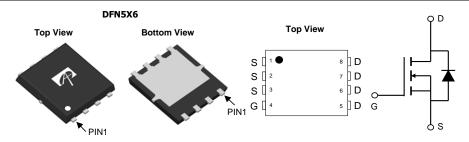
• High Frequency Switching and Synchronous Rectification

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 47A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 10.8 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 14.8 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity
AONS66923	DFN 5x6	Tape & Reel	3000

# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted Parameter Symbol

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V <sub>DS</sub>	100	V
Gate-Source Voltage		$V_{GS}$	±20	V
Continuous Drain	T <sub>C</sub> =25°C		47	
Current	T <sub>C</sub> =100°C	I <sub>D</sub>	30	Α
Pulsed Drain Current <sup>Ĉ</sup>		I <sub>DM</sub>	105	
Continuous Drain	T <sub>A</sub> =25°C	ı	15	A
Current	T <sub>A</sub> =70°C	IDSM	12	A
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	30	А
Avalanche energy	L=0.1mH	E <sub>AS</sub>	45	mJ
	T <sub>C</sub> =25°C	$P_{D}$	48	W
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	- P	19	VV
	T <sub>A</sub> =25°C	D	5.0	W
Power Dissipation A	T <sub>A</sub> =70°C	P <sub>DSM</sub>	3.2	VV
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

Thermal Characteristics						
Parameter		Symbol	Symbol Typ Max		Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	20	25	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	Т⊕ЈА	45	55	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2.1	2.6	°C/W	



### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		100			V
Zoro Coto Voltago Drain Curron	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V				1	μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		T <sub>J</sub> =55°C			5	μΛ
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		1.6	2.1	2.6	V
		$V_{GS}$ =10V, $I_D$ =20A			9.0	10.8	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance		T <sub>J</sub> =125°C		15.8	19.3	
		$V_{GS}$ =4.5V, $I_D$ =20A			11.5	14.8	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =20A	$V_{DS}$ =5V, $I_{D}$ =20A		50		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.72	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Cur	rent			47	Α	
DYNAMI	C PARAMETERS		•		-		
C <sub>iss</sub>	Input Capacitance				1725		pF
Coss	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz			360		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				7.5		pF
$R_g$	Gate resistance	f=1MHz		0.3	0.8	1.3	Ω
SWITCH	NG PARAMETERS		•		-		
Q <sub>g</sub> (10V)	Total Gate Charge				25	35	nC
<b>Q</b> <sub>g</sub> (4.5V)	Total Gate Charge	\/ -10\/ \/ -50\/	-204		12.5	18	nC
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =50V, $I_{D}$ =20A			6		nC
$Q_{gd}$	Gate Drain Charge		1		3.5		nC
Q <sub>oss</sub>	Output Charge	$V_{GS}$ =0V, $V_{DS}$ =50V			30		nC
t <sub>D(on)</sub>	Turn-On DelayTime				8.5		ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_{L}$ =2.5 $\Omega$ ,		3		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	R <sub>GEN</sub> =3Ω			23		ns
t <sub>f</sub>	Turn-Off Fall Time				3.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μ	I <sub>F</sub> =20A, di/dt=500A/μs		41		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, di/dt=500A/μs			156		nC

A. The value of  $R_{BJA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation P<sub>DSM</sub> is based on R <sub>8JA</sub> t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}\!\!=\!\!150^\circ\,$  C.

D. The  $R_{\text{\tiny BJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{\tiny BJC}}$  and case to ambient.

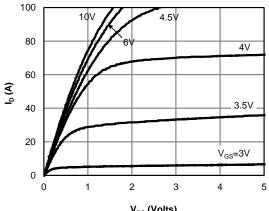
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

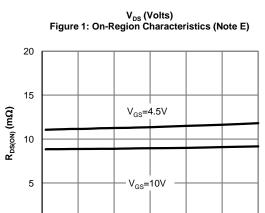
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





0

0

5

10

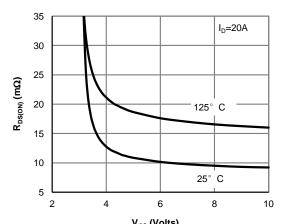
 $\rm I_D \, (A)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

20

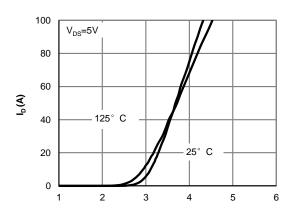
25

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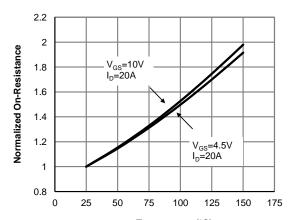
15



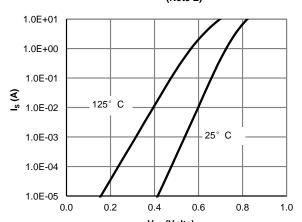
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



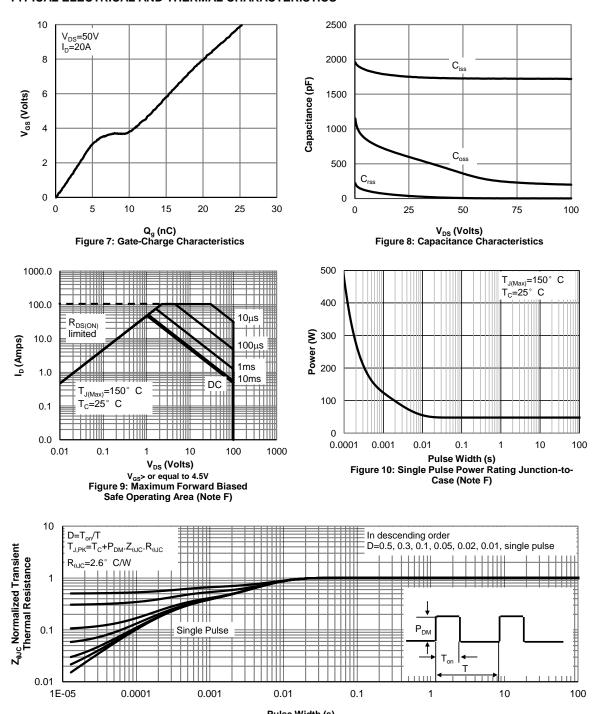
Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



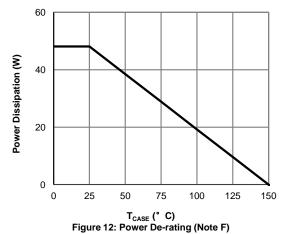
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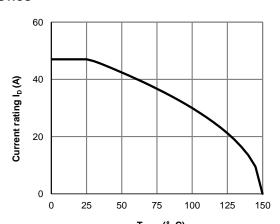


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

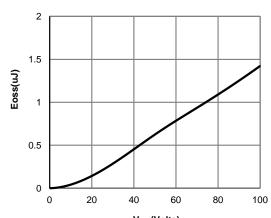


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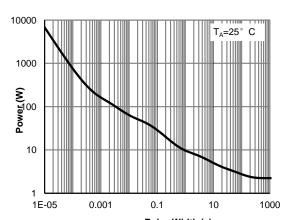




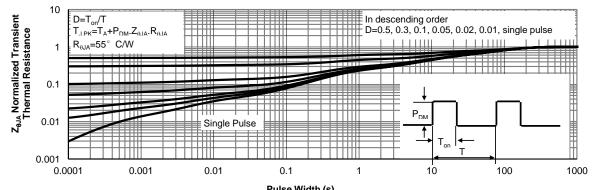
T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)



V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

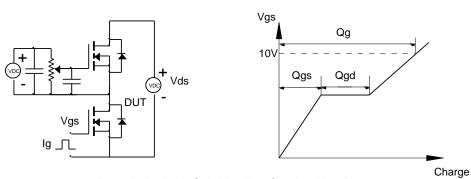


Figure B: Resistive Switching Test Circuit & Waveforms

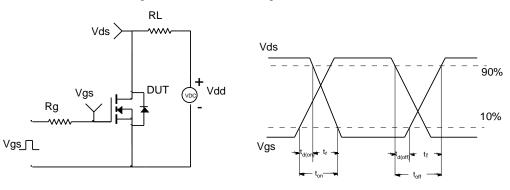


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

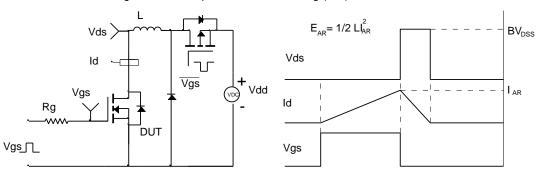
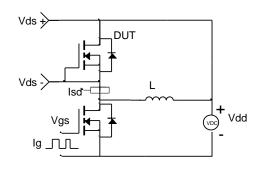
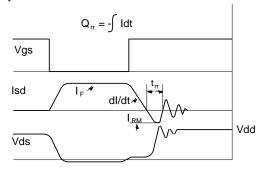


Figure D: Diode Recovery Test Circuit & Waveforms





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